# imall

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# Power MOSFET

## 60 V, 27.4 m $\Omega$ , 17 A, Single N–Channel

### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- $\bullet \ Low \ Q_G$  and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

	.j _0 0				
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage		V <sub>DSS</sub>	60	V	
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Current $R_{\theta JC}$ (Notes 1 & 3)	Steady	$T_{C} = 25^{\circ}C$	Ι <sub>D</sub>	17	А
		$T_{C} = 100^{\circ}C$		12	
Power Dissipation $R_{\theta JC}$ (Note 1)	State	$T_{C} = 25^{\circ}C$	PD	18	W
		$T_{C} = 100^{\circ}C$		9.1	
Continuous Drain		$T_A = 25^{\circ}C$	Ι <sub>D</sub>	7.5	А
Current R <sub>0JA</sub> (Notes 1, 2 & 3)	Steady State	$T_A = 100^{\circ}C$		5.3	
Power Dissipation $R_{\theta JA}$		$T_A = 25^{\circ}C$	PD	3.4	W
(Notes 1 & 2)		$T_A = 100^{\circ}C$		1.7	
Pulsed Drain Current	$T_A = 25^\circ C, t_p = 10 \ \mu s$		I <sub>DM</sub>	77	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body Diode)			I <sub>S</sub>	20	А
Single Pulse Drain–to–Source Avalanche Energy ( $I_{L(pk)} = 1 A$ )			E <sub>AS</sub>	48	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	8.3	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	44	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650  $\text{mm}^2$ , 2 oz. Cu pad.

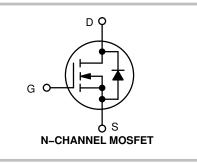
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



## **ON Semiconductor®**

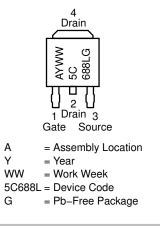
### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	
60 V	27.4 mΩ @ 10 V	17 A	
	40 mΩ @ 4.5 V		





### MARKING DIAGRAM & PIN ASSIGNMENT



### ORDERING INFORMATION

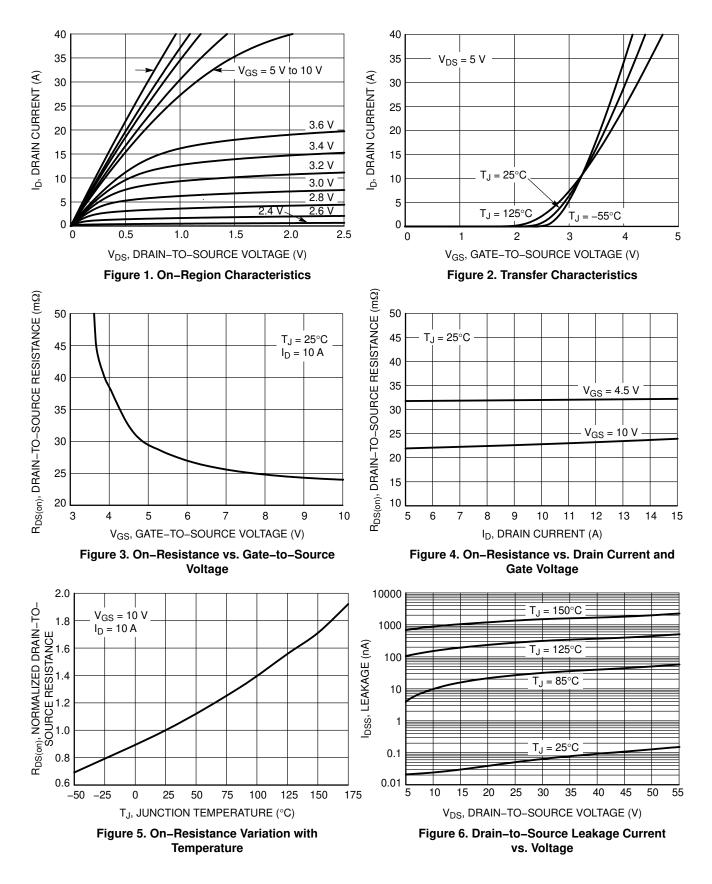
See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

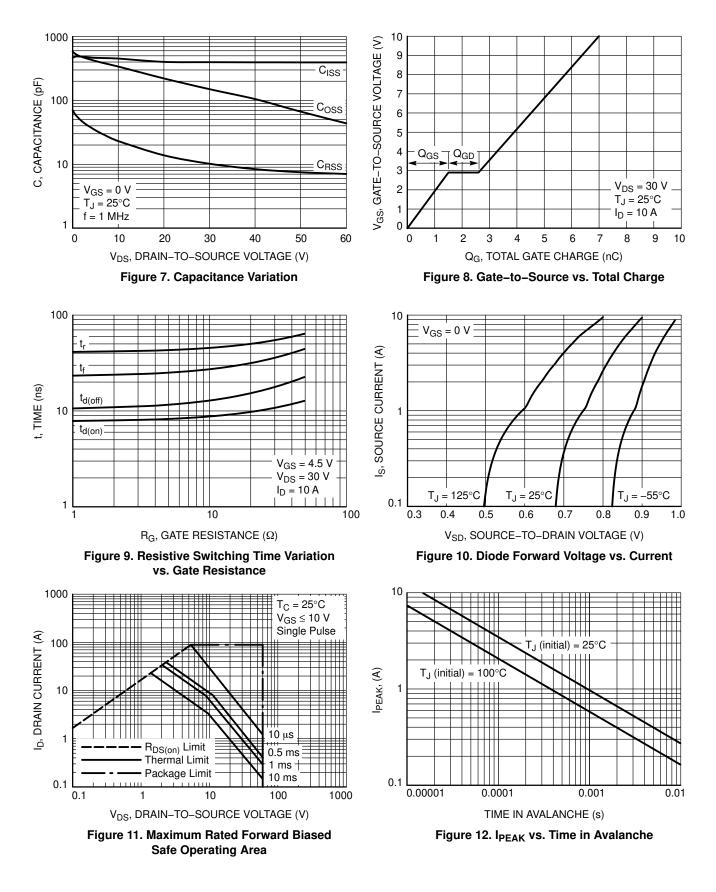
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					-	•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				27		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$ $T_J = 25^{\circ}C$				10	μA
		$V_{DS} = 60 V$	T <sub>J</sub> = 125°C			250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μA	1.2		2.1	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.4		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>E</sub>	<sub>D</sub> = 10 A		22.8	27.4	mΩ
		V <sub>GS</sub> = 4.5 V, I	<sub>D</sub> = 10 A		32	40	
Forward Transconductance	9fs	V <sub>DS</sub> = 55 V, I <sub>E</sub>	<sub>D</sub> = 10 A		20		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCES						-
Input Capacitance	C <sub>iss</sub>				400		pF
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 25 V$			170		
Reverse Transfer Capacitance	C <sub>rss</sub>				12		
Total Gate Charge	Q <sub>G(TOT)</sub>	TOT) $V_{DS} = 30 \text{ V},$ $I_D = 10 \text{ A}$ $V_{GS} = 4.5 \text{ V}$ $V_{GS} = 10 \text{ V}$	V <sub>GS</sub> = 4.5 V		3.4		nC
				7.0			
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 30 \text{ V},$ $I_D = 10 \text{ A}$			0.9		nC
Gate-to-Source Charge	Q <sub>GS</sub>				1.5		
Gate-to-Drain Charge	Q <sub>GD</sub>				1.1		
Plateau Voltage	V <sub>GP</sub>				2.9		V
SWITCHING CHARACTERISTICS (Note 5)							•
Turn–On Delay Time	t <sub>d(on)</sub>				8		ns
Rise Time	tr	V <sub>GS</sub> = 4.5 V. Vr			42		
Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>I</sub> I <sub>D</sub> = 10 A, R <sub>G</sub>	= 2.5 Ω		11		
Fall Time	t <sub>f</sub>				24		
DRAIN-SOURCE DIODE CHARACTERISTIC	S				•	•	
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A	$T_J = 25^{\circ}C$		0.9	1.2	V
			T <sub>J</sub> = 125°C		0.8		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt = 100 A/μs, I <sub>S</sub> = 10 A			17		ns
Charge Time	ta				8		1
Discharge Time	tb				9		1
Reverse Recovery Charge	Q <sub>RR</sub>				10		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**



### **TYPICAL CHARACTERISTICS**



## **TYPICAL CHARACTERISTICS**

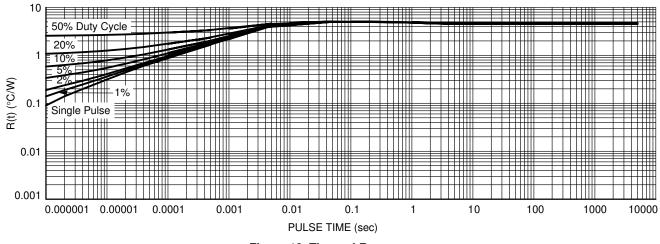


Figure 13. Thermal Response

#### **ORDERING INFORMATION**

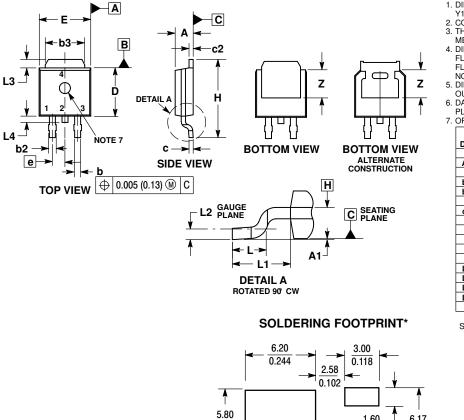
Order Number	Package	Shipping <sup>†</sup>
NTD5C688NLT4G	DPAK (Pb–Free)	2500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE) CASE 369C

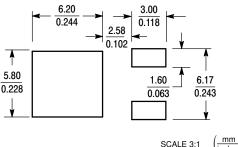
ISSUE E



NOTES:

- IDTES:
   DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
   CONTROLLING DIMENSION: INCHES.
   THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
   DIMENSIONS D AND E DO NOT INCLUDE MOLD ELASU PROTEINER OF DURDE AND DE DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- FLASH, PHOI HUSIONS, OR GATE BURHS SHALL NOT EXCEED 0.06 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  6. DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H. OPTIONAL MOLD FEATURE

OPTIONAL MOLD FEATURE.						
	INCHES		MILLIMETERS			
DIM	MIN	MAX	MIN	MAX		
Α	0.086	0.094	2.18	2.38		
A1	0.000	0.005	0.00	0.13		
b	0.025	0.035	0.63	0.89		
b2	0.028	0.045	0.72	1.14		
b3	0.180	0.215	4.57	5.46		
С	0.018	0.024	0.46	0.61		
c2	0.018	0.024	0.46	0.61		
D	0.235	0.245	5.97	6.22		
E	0.250	0.265	6.35	6.73		
е	0.090	BSC	2.29	2.29 BSC		
н	0.370	0.410	9.40	10.41		
L	0.055	0.070	1.40	1.78		
L1	0.114 REF		2.90	REF		
L2	0.020 BSC		0.51	BSC		
L3	0.035	0.050	0.89	1.27		
L4		0.040		1.01		
Z	0.155		3.93			



STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE

inches

4. DRAIN

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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